

Address





EMC Test Report

Applicant : Shenzhen Techtion Smart Electronics Co.,

Ltd

Room 902, 8th Floor, Unit 1, Building No. 2,

Xintianxia Chengyun Factory District, Vanke

City Community, Bantian Street, Longgang

District, Shenzhen

Product Name : Stretched Bar Display

Report Date : Nov. 12, 2024

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited







Contents

1. General Information	Anv	- 101	otek	Anbo		
1.1. Client Information	10.4 ×	ore b		, pote		And
1.2. Description of Device (EUT)	V	" "potek	Aupo	· · · · · · · · · · · · · · · · · · ·	e ^{tek}	Anbore
1.3. Auxiliary Equipment Used Durin	g Test	b	Aupop	Vu.		yoo
1.4. Description of Test Mode	Kapolek	Aup.		ootek	Anbor	6
1.5. Test Summary	" olek	Anbore		Yok	olodon	6
1.6. Test Equipment List	Ann	d ₉₋₁	otek	Aupo		otek
1.1. Client Information	Anbo.	g	Kolek	Vupose.	Vi.	10
1.8. EMS Performance Criteria	N	poter.	Ans.	100%),k	Anbo1
2. Power Line Conducted Emission Test.		400tek	Aupo.	······································	-ovek	12
2.1. Test Standard and Limit	pore	VI.	odan	er An	<u>.</u>	12
2.2. Test Setup	k abotek	Anbu	¢	, otek	Anbore	12
2.3. Test Procedure	"otek	Anbore	<i>b</i> .		yodn,	12
2.4. Test Results	Anv	(y	otek	Anbo	r	13
3. Radiated Emission Test (Below 1 GHz)A ^{nbo}	. b.,	Kotek	*upole.	ÞΩ	16
2.2. Test Setup 2.3. Test Procedure 2.4. Test Results 3. Radiated Emission Test (Below 1 GHz 3.1. Test Standard and Limit 3.2. Test Setup 3.3. Test Procedure 3.4. Test Results 4. Electrostatic Discharge Immunity Test 4.1. Test Specification 4.2. Test Setup	,a	opo _{ter}	VUr.	1991	e _K	
3.2. Test Setup		, botek	Anbor		18/e	16
3.3. Test Procedure	upore	Yu. Yek	200	Ter V.		16
3.4. Test Results	"polek	Anbo		wotek.	Anboro	17
4. Electrostatic Discharge Immunity Test	W. Watek	A.nbol	ρ		000	20
4.1. Test Specification	Anv	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	botek.	Anbo.		20
4.2. Test Setup	Anbe),_ b.	- Vek	Aupole.	Þ.	20
4.3. Test Procedure		"poter	And	کوپی	le _K	20
4.4. Test Results		wolek.	Anbore		494	2
4.2. Test Setup	upote.	Wun Yok	d9.,	otek l	'upo	23
5.1. Test Specification	"Potek	Aupo	r	wole _k	Anbore	23
5.2. Test Setup	P.,	k Anbo	,e.,	Yur.	20,5	23
5.3. Test Procedure	And		490tek	Aupo.	bes	23
5.4. Test Results	4 Ant	or b	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	anbote,		24
6. Electrical Fast Transient/Burst Immuni	ty Test	, abotek	Anbe)	otek	
6.1. Test Specification		HO/6K	Anbore	, V		26
6.2. Test Setup	Vupo _{fer.}	Ann		ootek	Aupo	26
6.3. Test Procedure	Modiek	Aupo.		10 ¹ 0 ¹	Aupole	27
6.4. Test Results	V	k pob	7,6 c	Ann		o ^{tek} 27
7. Surge Immunity Test	Anbe		otek	Anbor	br.	29
7.1. Test Specification	.K 45'	pore		apo ^{te}		29
7.2. Test Setup		KAPOICK	Anbo	ję	otek	<u>Anbore</u> 29
7.3. Test Procedure	po.	h. "Olek	lodna.	e. Vu		29
7.4. Test Results	Pupoter	Vun.	6	100tek	Aupo.	29
5.4. Test Results	tek	Anbolo	b.	cote ^k	Anbore	3
8.1. Test Specification	V.,.	10.3. 10.	ofer	Ann		ootek31
8.2. Test Setup	Anbo	·····	wotek.	Anbore		31
hen Anbotek Compliance Laboratory Limite	d	pole	Coc	le: AB-FMC-0	12-d	THE PROPERTY.



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oduct Safety Anbotek	Report No.:	1819C400	62512601-N	11 Am	Page 3 of	42	
8.3. Test Procedure	Aupor	······································	الأمير العابي	ope, Yun	Vey	.32	
8.4. Test Results	000,	ion War		"Potek"	Yupo.	32	e/F
APPENDIX I TEST SETUP PH	IOTOGRAPH	"otek	Anbore	V. V.	"upoler	. 34 ^{Amb}	
APPENDIX II Photo document	ation	Un.	potek	Anbo	otek	.38 📈	100

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Code: AB-EMC-02-d

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Model No.

Report No.: 1819C40062512601-M1

TEST REPORT

Applicant Shenzhen Techtion Smart Electronics Co., Ltd

Manufacturer Shenzhen Techtion Smart Electronics Co., Ltd

Stretched Bar Display Product Name

TS-286THD, TS-XXXTHD/TS-XXXPHD ("X" stands for a-z or number or

empty, or - or #; Different combinations of products represent different sales

channels and customers; Does not affect product safety and

electromagnetic compatibility.)

Trade Mark

DC12V Rating(s)

EN 50121-3-2:2016+A1:2019; Test Standard(s)

(IEC 61000-4-2; IEC 61000-4-3; IEC 61000-4-4;

IEC 61000-4-5; IEC 61000-4-6)

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 50121-3-2 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt:	Oct. 15, 2024
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Date of Test:	Oct. 15~Oct. 24, 2024
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stek Nupoto Will	Jee rivery
Prepared By:	An otek Aupoter Aug Nek Jupote
otek Aupore Will Tek Vuporen	(Yee Huang)
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And Ando	(ingling)in
Approved & Authorized Signer:	Von William William Vierk
Otek Aupor Ar.	(KingKong .lin)





1. General Information

1.1. Client Information

Applicant	: Shenzhen Techtion Smart Electronics Co., Ltd				
Address	Room 902, 8th Floor, Unit 1, Building No. 2, Xintianxia Chengyun Factory District, Vanke City Community, Bantian Street, Longgang District, Shenzhe				
Manufacturer	: Shenzhen Techtion Smart Electronics Co., Ltd				
Address	Room 902, 8th Floor, Unit 1, Building No. 2, Xintianxia Chengyun Factory District, Vanke City Community, Bantian Street, Longgang District, Shenzhe				
Factory	: Shenzhen Techtion Smart Electronics Co., Ltd				
Address : Room 902, 8th Floor, Unit 1, Building No. 2, Xintianxia Chengyun Factory District, Vanke City Community, Bantian Street, Longgang District, Shenz					

Report No.: 1819C40062512601-M1

1.2. Description of Device (EUT)

Product Name	:	Stretched Bar Display
Model No.	:	TS-286THD, TS-XXXTHD/TS-XXXPHD ("X" stands for a-z or number or empty, or - or #; Different combinations of products represent different sales channels and customers; Does not affect product safety and electromagnetic compatibility.)
Trade Mark	:	N.A Anbotek Anbotek Anbotek Anbotek Anbotek
Test Power Supply	:	AC 230V, 50Hz
Test Sample No.	:	1-1-1 Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Product	:	AC ADAPTOR
Description		Model: KT60W120500B3
		Input: 100-240V~50/60Hz 1.5A
		Output: 12.0V 5.0A 60.0W

Remark: (1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

- (2) All samples are the same except the model number and dimension, so we prepare "TS-286THD" for test only.
- (3) The test report 1819C40062512601-M1 supersedes the test report 1819C40062512601 which is withdrawn.

1.3. Auxiliary Equipment Used During Test

P	N/A	And	Potek	Anbor	K. Stek	Vupole.	Du
		100	100		100	Par.	

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1.4. Description of Test Mode

Pretest Mode			Description		
Mode 1	Votek	Aupolek	And Onek	Anbotek	Anbo

Report No.: 1819C40062512601-M1

For Mode 1 Block Diagram of Test Setup

AC Mains	oter	AC ADAPTOR	abotek	AND THE
	rek	Vigoria 1011	A.	- abole

1.5. Test Summary

Test Items	Test Mode	Status
Power Line Conducted Emission Test	Mode 1	Anbolein P
Radiated Emission Test (Below 1 GHz)	Mode 1	P P Anbotek
Electrostatic Discharge Immunity Test	Mode 1	hotek P Anbotek
RF Field Strength Immunity Test	Mode 1	Anbotek P Anbo
Electrical Fast Transient/Burst Immunity Test	Mode 1	Prok
Surge Immunity Test	Mode 1	tek Panbotek
Injected Currents Susceptibility Test	Mode 1	Thotek P Amboli
DC Power Supply Test	Mode 1	Anbore
P) Indicates "PASS". F) Indicates "Fail". N) Indicates "Not applicable"	Potek Vipotek Vipotek	Aupotek Aupotek

N) Indicates "Not applicable".

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1.6. Test Equipment List

	200	The state of the s		D's.	100	V Ub.
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
48	L.I.S.N.	tek upotek	Aupor	, vo	lek Aupole	Au.
1.	Artificial Mains	Rohde & Schwarz	ENV216	100055	Sept. 09 2024	1 Year
polo	Network	Aupoten Aug	de You	otek b	4000	potek Anto
nbote	Three Phase V-type	abotek An	, bo.	E215040D	Anbore. Ar	16K
2.	Artificial Power	CYBERTEK	EM5040DT	T001	Jan. 17, 2024	1 Year
Vu	Network	Aupo	potek	Anbor	V. Otok	Anbote
3.	EMI Test Receiver	Rohde & Schwarz	ESPI3	100926	Sept. 09, 2024	1 Year
ek 1	Software Name	Talek Tale Appore	AND OSA	V NI/A 30	Jiek VIVO VUDOS	V NIA Sole
4.	EZ-EMC	Farad Technology	ANB-03A	N/A	N/A Anbo	Pok N/A Mapos
MA		0/0		VD.V	70	V to

⊠ Radiated Emission Test (Below 1 GHz)

		K			15.7	1.0.1
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Jan. 17, 2024	1 Year
2.	Pre-amplifier	Schwarzbeck	BBV-9745	9745-075	Jan. 17, 2024	1 Year
Inhotek	Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	01109	Oct. 16, 2022	3 Year
4.	Software Name EZ-EMC	Farad Technology	EMEC-3A1	N/A	N/A	N/A

⊠ Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.,,,	ESD Simulators	emtest	ESD NX30.1	11936	Mar. 11, 2024	1 Year

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⊠ RF Field Strength Immunity Test

200	, V	1.0°		187	V U P	- Nove
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	Agilent	N5181A	MY5014310 7	Jan. 23, 2024	1 Year
2.	Power Meter	Agilent	E4417A	MY4510138 4	Jan. 23, 2024	1 Year
3.	Amplifier	Micotop	MPA-80-100 0-600	MPA211031 8	Jan. 17, 2024	1 Year
4.	Amplifier	Micotop	MPA-1000-6 000-100	MPA211032 7	Jan. 17, 2024	1 Year
5.	LogPerAntenna	Schwarzbeck	VULP 9118E	01012	N/A	N/A
6.	Microwave LogPer. Antenna	Schwarzbeck	STLP 9149	00788	N/A	N/A
7.	Power Sensor	KEYSIGHT	E9323A	US40410647	Jan. 23, 2024	1 Year
8.	Power Sensor	KEYSIGHT	E9323A	MY5310000 7	Jan. 23, 2024	1 Year
9.	Electric field Probe	Narda S.T.S /PMM	EP 601	811ZX10351	Jan. 19, 2024	1 Year
10.	Software	EMtrace	EM 3	Aupo	N/A	N/A

⊠ Electrical Fast Transient/Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	Surge Generator	TESEQ	NSG 3060	1480	Jan. 18, 2024	1 Year
2.	CDN	TESEQ	CDN 3061	1408	Jan. 18, 2024	1 Year
3.	EFT-Clamp	PRIMA	EFT61004B	PR10114282	Jan. 17, 2024	1 Year

⊠ Surge Immunity Test

⊠Sur	ge Immunity Test	Anbotek Anbotel	riek Aupo	otek Aup.	Yek Vupore	otek Anbol
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Anb'	Combined Wave Lightning Surge Simulator	3Ctest	CCS600	ES3771702	Jan. 17, 2024	1 Year
2.	Three Phase Power Coupling Network	3Ctest	SEPN69100 T	ES0801757	Jan. 17, 2024	1 Year
3.otel	Telecom port surge generator	Anbo PMI An	TW101	190411	Jan. 18, 2024	1 Year

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Anbotek

Report No.: 1819C40062512601-M1

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	R&S	SMC100A	104424	Feb. 04, 2024	1 Year
2.	Anbot CDN Anbo	FRANKONIA	CDN - M2+ M3	A2210178/20 12	Jan. 17, 2024	1 Year
3.	6dB Attenuator	FRANKONIA	DAM 26W	1172202	Sept. 09, 2024	1 Year
4.	Software	EMtrace	EM 6	Ofer Vun	N/A	botek N/A Ar
Anbor 5.	EM-Clamp	FRANKONIA	EMCL-20	18101728-01 03	Jan. 17, 2024	1 Year
6.	Power Meter	Agilent	E4419B	GB43312730	Feb. 04, 2024	1 Year
e¥7.	Amplifier	Micotop Micotop	MPA-0.15-23 0-110	MPA2110317	Feb. 04, 2024	1 Year
.8°	Power Sensor	Agilent	E9304	otek / Ant	Feb. 04, 2024	1 Year
9.	Power Sensor	Agilent	E9304	MY41498663	Feb. 04, 2024	1 Year
10.	ootek CDN nootek	TESEQ	CDN M432-3LN	33659	Jan. 17, 2024	1 Year

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Code: AB-EMC-02-d

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1.7. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 434132

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 434132.

Report No.: 1819C40062512601-M1

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

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Report No.: 1819C40062512601-M1 Page 11 of 42

1.8. EMS Performance Criteria

Performance criterion A

The EUT shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the EUT is used as intended. If the performance level is not specified by the manufacturer, this may be derived from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

The EUT shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer. when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. However, during the test degradation of performance is allowed but no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and and what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Ternporary loss of function is allowed during the test. provided the function is self-recoverable or can be restored by the operation of the controls.

If. as a result of the application of the tests defined in this standard, the EUT becomes dangerous or unsafe, it shall be deemed to have failed the test.

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2. Power Line Conducted Emission Test

2.1. Test Standard and Limit

Test Standard:	EN 50121-3-2	Anbole	Yu. Polek	Aupotek
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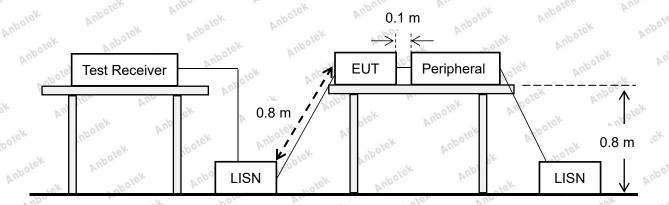
Report No.: 1819C40062512601-M1

□ Limits for conducted emission at the AC or DC mains power ports

Fraguency (MIII-)		Limits (dBμV)						
Frequency (MHz)		(Quasi-peak Leve	əl				
0.15 ~ 0.50	upo	Vupolek	99.0	A. Sporek	Anboles			
0.50 ~ 30.00	Aupo	Anbotek	93.0	An	Anbolen			
io. Vun	200	h-,	, , ofe.	Vien				

Remark: The lower limit shall apply at the transition frequencies.

2.2. Test Setup



2.3. Test Procedure

The table-top EUT is placed on a non-conductive table 0.8 m above the horizontal ground reference plane, and the back of the EUT is 0.4 m away from the vertical ground reference plane, and at least 0.8 m from any other metal surface or ground plane. The floor-standing EUT is placed on an insulating support 0.1 m above the horizontal ground reference plate, at least 0.8 m away from other metal objects.

Connect EUT to the power mains through an LISN. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the center into a bundle no longer than 0.4 m, so that its length is shortened to 1 m. All the peripherals are connecting to the other LISN.

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The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

Report No.: 1819C40062512601-M1

The identification of the frequency of highest disturbance with respect to the limit was found by investigating disturbances at a number of significant frequencies. The probable frequency of maximum disturbance had been found and that the associated cable and EUT configuration and mode of operation had been identified.

Set the test-receiver to quasi peak detect function and average detect function, and to measure the conducted emissions values.

2.4. Test Results

PASS

The test curves are shown in the following pages.





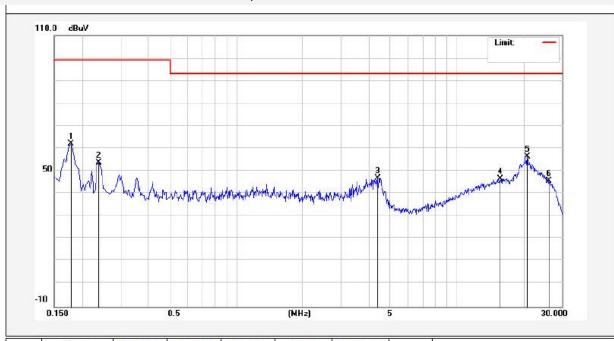
Power Line Conducted Test Data

Test Site: Shielded Room
Test Specification: AC 230V, 50Hz

Comment: Live Line

Temp.: 23.9℃ Hum.: 50%

Report No.: 1819C40062512601-M1



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1777	44.20	17.82	62.02	99.00	-36.98	QP	
2	0.2378	36.01	17.82	53.83	99.00	-45.17	QP	
3	4.3606	29.07	17.85	46.92	93.00	-46.08	QP	
4	15.7179	28.48	18.16	46.64	93.00	-46.36	QP	
5	20.8137	38.04	18.32	56.36	93.00	-36.64	QP	
6	26.1393	26.98	18.55	45.53	93.00	-47.47	QP	

Note: Result = Reading + Factor Over Limit = Result - Limit

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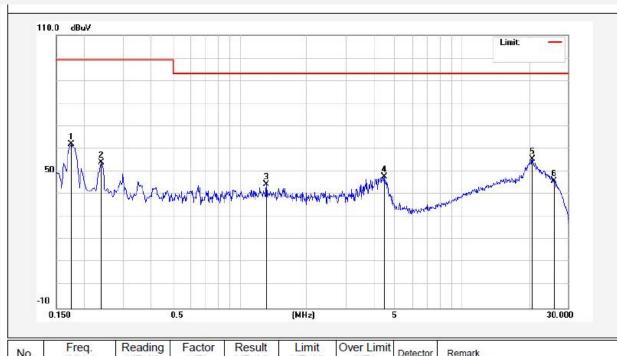


Power Line Conducted Test Data

Test Site: Shielded Room **Test Specification:** AC 230V, 50Hz Comment: **Neutral Line**

Temp.: 23.9℃ Hum.: 50%

Report No.: 1819C40062512601-M1



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1739	44.47	17.83	62.30	99.00	-36.70	QP	
2	0.2378	36.12	17.82	53.94	99.00	-45.06	QP	
3	1.3167	26.54	17.86	44.40	93.00	-48.60	QP	
4	4.4775	29.78	17.85	47.63	93.00	-45.37	QP	
5	20.7038	37.33	18.31	55.64	93.00	-37.36	QP	
6	25.8638	27.49	18.53	46.02	93.00	-46.98	QP	

Note: Result = Reading + Factor Over Limit = Result - Limit

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3. Radiated Emission Test (Below 1 GHz)

3.1. Test Standard and Limit

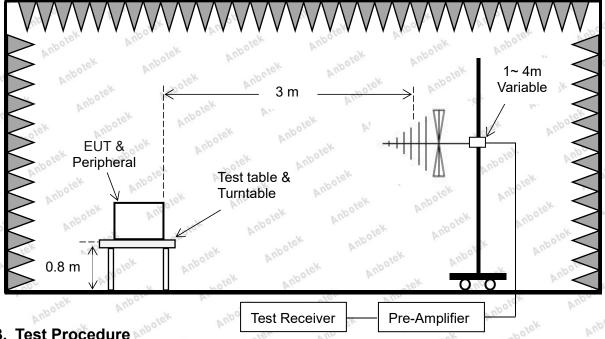
Test Standard EN 50121-3-2	The state of the s
----------------------------	--

Report No.: 1819C40062512601-M1

Limit for radiated emissions at frequencies up to 1 GHz

Frequency (MHz)	Distance (Meters)	Field Strengths Limit (dBμV/m)
30 ~ 230	Anbore Anbore	Antotel 50 Anbotel
230 ~ 1000	Anbountek 3 Anbotek Anb	57 Anbolek
Remark: The lower limit shall ap	oly at the transition frequencies.	Anbore Anborek Anbore

3.2. Test Setup



3.3. Test Procedure

The table-top EUT is placed on a non-conductive table 0.8 m above the horizontal ground reference plane. The floor-standing EUT is placed on an insulating support 0.1 m above the horizontal ground reference plane.

The EUT was set 3 m away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 m to find out the maximum emission

The turntable can rotate 360 degree to determine the position of the maximum emission level.

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The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

The bandwidth of the Receiver is set at 120 kHz.

3.4. Test Results

PASS

The test curves are shown in the following pages.



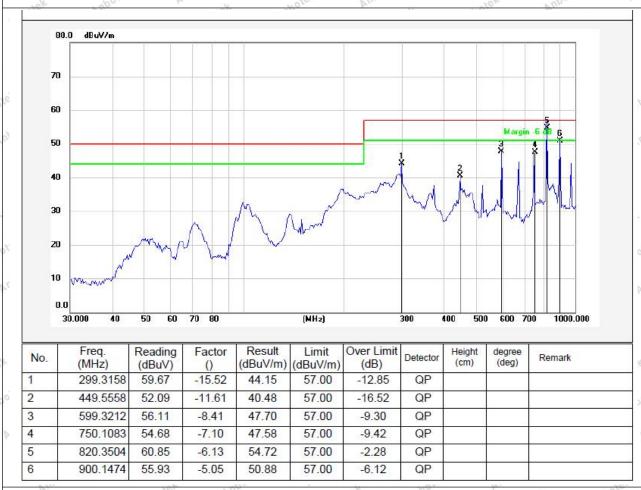


Test item: Radiation Test Polarization: Horizontal

Standard: (RE)EN 50121-3-2 Power Source: AC 230V, 50Hz

Frequency Range: $30\text{MHz} \sim 1000\text{MHz}$ Temp.(°C)/Hum.(%RH): 25.1(°C)/51%RH

Distance: 3m



Note: Result= Reading + Factor Over Limit=Result-Limit

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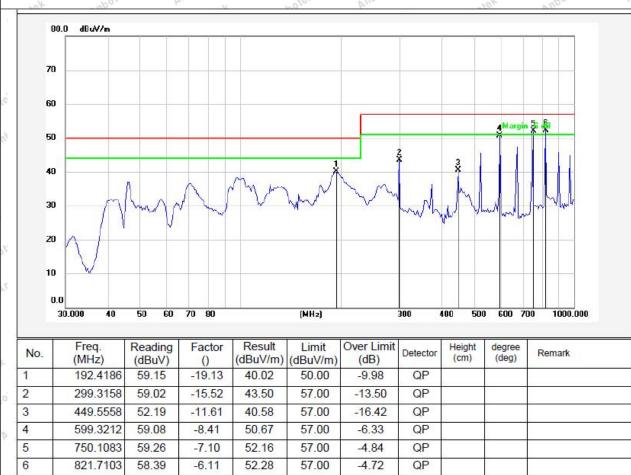


Test item: Radiation Test Polarization: Vertical

Standard: (RE)EN 50121-3-2 Power Source: AC 230V, 50Hz

Frequency Range: $30\text{MHz} \sim 1000\text{MHz}$ Temp.(°C)/Hum.(%RH): 25.1(°C)/51%RH

Distance: 3m



Note: Result= Reading + Factor Over Limit=Result-Limit

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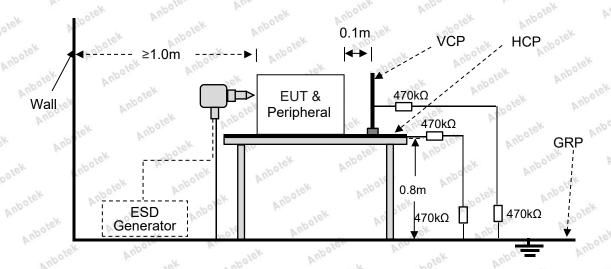
4. Electrostatic Discharge Immunity Test

4.1. Test Specification

Test Standard :	EN 50121-3-2	Aupole	All.	Anbotek
Basic standard :	IEC 61000-4-2: 2008	Aupore	Am	Anbotek
Performance criteria:	B nbotek	Anbore	ak abotek	Anbo
Test Level :	± 8kV (Air Discharge)	± 6k\	/ (Contact Disch	arge)

Report No.: 1819C40062512601-M1

4.2. Test Setup



4.3. Test Procedure

- a. In the case of air discharge testing, the climatic conditions shall be within the following ranges:
- Ambient temperature: 15°C to 35°C;
- Relative humidity: 30% to 60%;
- Atmospheric pressure: 86 kPa (860 mbar) to 106 kPa (1060 mbar)
- b. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- c. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted: - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate. - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge. - The contact discharge test shall not be applied to such surfaces.
- d. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered

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for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

- e. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final test level should not exceed the product specification value in order to avoid damage to the equipment.
- f. The test shall be performed with both air discharge and contact discharge. The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied. For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- g. Ensure that the applied charge on the EUT has been dis-charged before next ESD pulse.

4.4. Test Results

PASS

Please refer to the following page.

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Electrostatic Discharge Test Results

Test Result:	⊠ Pass □	Fail And	Temperature:	botek	23.5℃	Anbore	otek
Power Supply:	AC 230V, 50H	ž ^{ek}	Humidity:	Anbotek	53%	k Vu	a nbotek
otek Anbore A	otek t	upolen	Ann	abotek	Anbo	-V-	
Anbotek Anbotek Lo	ocation	Anbotek	A-Ai	Kind r Discharge act Discha	Je.	Result	Y Ann
Air discharge: ±2.0 kV, ±4	.0 kV, ±8.0 kV	Anbo	Lor Vup.	discharge:	Nek	Aupor	potek
Screen	11.	points	and otek	A Otek	⊠A	. □ B	C/c
Slot	Anbotek 4	points	Anbotek	A Anbore	⊠A	_{loo} le B	Cup
Metal	Anbore 4	points		C Ann	⊠A	B	□С
HCP Anbotek Anbotes	And And	points N	Olek Vup.	Cer	⊠A	□B	□C
VCP of the front	wotek 4	points	Aupolo	Chotek	⊠A	B	C
VCP of the rear	Anbotek 4	points	Andrek	C Anbotel		B	C
VCP of the left	Anbotek 4	points	k Anbotel	C Ano	⊠A	□ Bek	ПС
VCP of the right	Anbole 4	points	ooiek Ant	Orek C	⊠A	Bo	C
stek Anbolek An	otek Anbo	botek	Anbolek	Aupor Polek	Anborek		Aupole.
Note: N/A.	Vupor Votek	Aupolek	Anbore	Augusto	k Aup	, tek	Anbo

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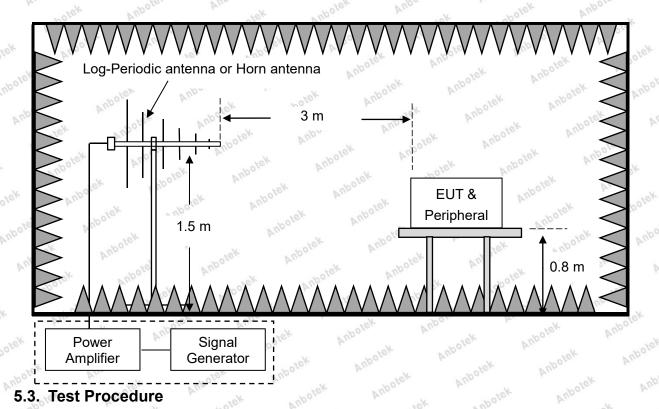
5. RF Field Strength Immunity Test

5.1. Test Specification

Test Standard:	EN 50121-3-2	Pin Pop	Aupoli	Se Vuo	otek Anbotek		
Basic standard:	IEC 61000-4-3	3: 2020	votek Ar	Poter Yu	stek anbote		
Performance criteria:	A botek	A Ores AT	A	Aotek	Mark Mark		
Frequency Range:	80MHz to 800MHz	800MHz to 1GHz	1.4GHz to 2GHz	2GHz to 2.7GHz	5.1GHz to 6GHz		
Test level:	20 V/m	20 V/m	10 V/m	5 V/m	3 V/m		
Modulation:	1kHz Sine Wave, 80%, AM Modulation						
Frequency Step:	1 % of preced	1 % of preceding frequency value					
Polarity of Antenna:	Horizontal and	d Vertical	upo 'ek	nbotek	Aupolo K		
Test Distance:	3 m	anbotek	Aupo	b. potek	Anbole, An		
Antenna Height:	1.5 m	abotek	Aupore	VII.	Anbotek		
Dwell Time:	at least 0.5s	ok abotek	Aupole.	Ano	tek Anboiek		
tek Anbotek A	upotek Aupo	upotek Vup	Jiek Aup	hotek And	nbotek Anbotek		

Report No.: 1819C40062512601-M1

5.2. Test Setup



The procedure defined in this part requires the generation of electromagnetic fields within which the test

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sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

- a. The antenna is placed 3 m from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the antenna.
- b. The test shall normally be performed with the generating antenna facing each side of the EUT. When equipment can be used in different orientations (i.e. vertical or horizontal) all sides shall be exposed to the field during the test. When technically justified, some EUTs can be tested by exposing fewer faces to the generating antenna. In other cases, as determined for example by the type and size of EUT or the frequencies of test, more than four azimuths may need to be exposed.
- c. The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.
- d. The step size of the frequency is set to 1%. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond. However, the dwell time should not exceed 5 s at each of the frequencies during the scan.

5.4. Test Results

PASS

Please refer to the following page.

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RF Field Strength Susceptibility Test Results

Test Result:	Anbotek		Pass	☐ Fail	Temperatu		ek Ar	23.3℃	Ant	otek
Power Supply:	Anbo	AC	230V	, 50Hz	Humidity:	Anbo	hotek	51%	,K	Anbore.
rak abotel	P	Upor	26	h. potek	Aupole	P	up tok	20	potek	Vupo
Frequency Range	Ante Pola			R.F. Field Strength	Dwell Ti	DOFO.	Azin	nuth	Anbotek Re:	sult
Anbore	Aupolek V		PU.	poten Aug	ootek	Aupotek	Fre	ont		botek
80 MHz ~ 800 MHz	H√	V	. V	20 V/m	nbotek 1s	Anb	o ^{tek} Re	earnbore eft Anbor	ek	A B
ek hote	1/4	nbot		All	Aupolen	000	Rig	ght	potek	C Anbote
upor N.	potek	P.	pose	b.	lode	ek	Anb Fro	ont	Anbotek	An
800 MHz ~	401	. ,	Anbol	ek Auporen	ek , , ,	hotek	Re	ear		A
MI OI IZ	Anborel	V	27	20 V/m	ibotek 15°	Anbote	Lé	eft	P.I.	В
Anbotek	Anbo	Note.		upotek A		b.	ote ^k Rig	ght _{Anbotes}	N.	uno rotek
otek Anbotek	Aug		You	Aupolek.	Aupolok	V.	_{∽ote} /Fro		Ter.	Vuga.
56	e/k	Anbo	, al-	10 V/m	Anbotek		Re	ear		A Anbo
1.4GHZ ~ ZGHZ	ibotek H/	V	nbotek	io Will	1s Anbo	FOR	And Le	eft	nbotek	C by
Anbo	hotek		10.1.		484	upotek	Riç	ght	700	rek
Aupolen	Anbore	J/F	D	upotek Anbe	nbotek	Anbok	Fro	ont		rAotek
2GHz ~ 2.7GHz	And H	V _{ek}		5 V/m	mbo.	h.,	botek Re	ar _{Anbote}		B abotek
tek apole.	An	O.	401	Anbotek	Anbote1s	b.	, oteVL€	eft Ant	otek	C
100	tek	Anb	otek k	Potek	Anborek		Rig	ght	Aupolek	Vup.
Aupore Au	nbotek		Aupore	otek 2 W. Anbotel	Anb	otek	^A Fro	ont		A
5.1GHz ~ 6GHz	AnboH*/	V	ARIO	3 V/m	.a\ 1c	Anbotek	Re	70.		o'B'
Anbore	Anbo'	e/k	9	3 V/m	*ek	Anbo	6-	eftabore	K	Cotek
k Aupolek		. 40		200101	Aupo	b.	sbotek Rig			Vu.
Note: N/A	, P,	pote	400	Anbotek	Anbotek	r. b.	Anbotek	An	ootek	Anbotek
100	Yek.	201	DOLO	V.	31000	100	VUID		rek	Anb

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6. Electrical Fast Transient/Burst Immunity Test

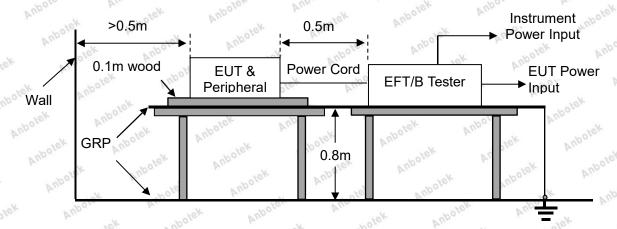
6.1. Test Specification

Test Standard:	EN 50121-3-2
Basic standard:	IEC 61000-4-4: 2012
Performance criteria:	Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Test Level:	≥ kV, AC mains power ports
	☐ 2 kV, DC network power ports
	☐ 2 kV, Signal/Control ports

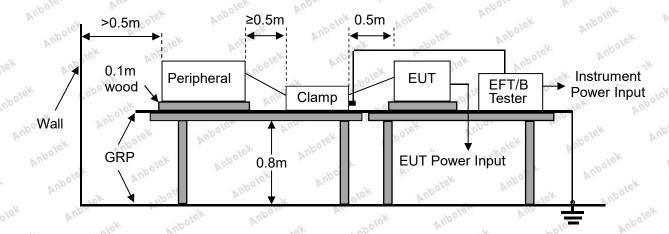
Report No.: 1819C40062512601-M1

6.2. Test Setup

AC mains power ports and DC network power ports:



Analogue/digital data ports:



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6.3. Test Procedure

The table-top EUT is placed on a table that is 0.8 m height, a ground reference plane is placed on the table, and uses 0.1 m insulation between the EUT and ground reference plane. The floor-standing EUT is placed on a ground reference plane and insulated from it by an insulating support with a thickness of 0.1 m. This reference ground plane shall project beyond the EUT by at least 0.1 m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5 m.

Report No.: 1819C40062512601-M1

All cables to the EUT shall be placed on the insulation support 0.1 m above the ground reference plane. Cables not subject to electrical fast transients shall be routed as far as possible from the cable under test to minimize the coupling between the cables.

6.4. Test Results

PASS

Please refer to the following page.





Report No.: 1819C40062512601-M1 Page 28 of 42

Electrical Fast Transient/Burst Test Results

Test Result:	VUQQIEK [☑ Pass ☐ Fail	Aupotek Aupo	Temperature:	24.4℃
Power Supply:	Anbore A	C 230V, 50Hz	Anbotek A	Humidity:	54%
rek anbotek	Anbo	ok boiel	Anbore	Air. Otek Vul	loter Aug
Anbore Ports And	Polarity	Inject Time(s)	Repetition Frequency (kHz)	Test Voltage (kV)	Result Anno
⊠ AC mains power ports	Vup J ek ∀up J ek	120 s	⊠ 5 □ 100	2.0 kV	⊠A □B □C
☐ DC network power ports	E ± Anbo	120 s	⊠ 5 □ 100	2.0 kV	□A □B □C
☐ Signal/Control ports	Anbolet	120 s	⊠ 5 □ 100	2.0 kV	□А □В □С
Note: N/A	Anborek	Anborotek	Anbotek Ant	potek Anbotek	Anbotek

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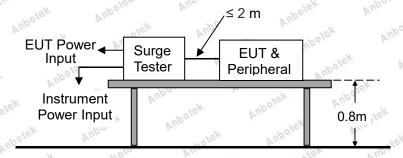
7. Surge Immunity Test

7.1. Test Specification

	Test Standard:	EN 50121-3-2					
C ₀	Basic standard:	IEC 61000-4-5: 2014+A1:2017					
S)	AC nower port	⊠ 1 kV, Line to Line, Criterion B					
Test	AC power port:	⊠ 2 kV, Line to Ground, Criterion B					
level		1 kV, Line to Line, Criterion B					
	DC network power port:	☐ 2 kV, Line to Ground, Criterion B					
Number of surges		5 (for each combination of parameters)					
Repetition rate		1 minute / time					
Polarity:		Positive / Negative					
Phase angle:		0°, 90°, 180°, 270° (Only AC mains power ports)					

Report No.: 1819C40062512601-M1

7.2. Test Setup



7.3. Test Procedure

Table-top EUT is placed on a table of 0.8 m heights above a metal ground reference plane. Floor standing EUT is placed on a ground reference plane and insulated from it by an insulating support with a thickness of 0.1 m. The length of the power cord between the EUT and the coupling/decoupling network is not more than 2 m, and the length of the interconnection line between the EUT and the coupling/decoupling network is not more than 2 m. The tests were done at repetition rate 1 per minute.

7.4. Test Results

PASS

Please refer to the following page.

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Surge Immunity Test Results

Test Result:	Aupotek	⊠ Pass	s 🗌 Fail	Temperatur	e:	2	4.4℃	Anbo	16K
Power Supply :	Aupo	AC 230\	/, 50Hz	Humidity :	Aupor	sk 5	4%	4 6	'upoter ote
rek anborek	b	,nbo	Polek	Anbore	Vie	rek	Anl	oter	AUD
Location	Pola	arity	Phase Angle	Number Pulse	2000	ulse Vo (kV		Res	ult
	t (Wav	eform: 1.	2 us / 50 us (8	us / 20us))	hotek	Ank	OFER	Anbo	nek-
ek L-Nabotek	Anbo	otek h	⋈ 0°⋈ 90⋈ 180°⋈ 270	5	Aupotek	1 k\	Anbotek	⊠A□E	3 □ C
botek Aupote	· ·	*upotek	⋈ 0°⋈ 90⋈ 180°⋈ 270	-0°5	Anbol	1,k\	Am	⊠A□E	3 🔲 Č
L-GND	otek	Anb	⋈ 0°⋈ 90⋈ 180°⋈ 270	1 5	otek	2 k\	, ox	⊠A□i	3 □ C
Anbotek	Anbore	· ·		100	Anbotek	2 k\	anbotek	⊠A□i	3 □ C
N CND	Ant	ole, olek	⋈ 0°⋈ 90⋈ 180°⋈ 270	A11.	Anbo	2 k\	Anbo	⊠A□E	B □ C
N-GND	botek	Aupote)	⋈ 0°⋈ 90⋈ 180°⋈ 270	2 010	ik b	2 k\	,ex	⊠A□E	В□С
□ DC network p	ower po	rts (Wa	veform: 1.2 us	/ 50 us (8 us / :	20us))	Vien	-otek	Anbot	ek
P to N	Anbo4	3/4	Aupore b	oborek 5	Aupoter	1 k\	no tek	□ A □ E	в□с
Ann	. 60	potek	Aupoton	bote/5	Vupore,	1 k\	Ans	ADE	В□С
P to GND	ek +	anbotek	Anhora	5.4	Anb	2 k\	Ans		В□С
Anboleko Oliva Anbo	*ek	· Jodge	K Aupoles		e/r	2 k\	/	□ A □ E	В□С
N to GND	upo,	- h.	ootek / Anb	5	yolek.	2 k\	YOK.	□ A □ E	в□С
Aupo tek	Vupo.	ok k.	anbotek /	Anbole 5 Ar	, bolek	2 k\	potek	□ A □ E	в□с
Note: N/A	Anbo	rek	Anbotek	Anbore	Vu.	3/K	Anbore	P	'up, "ote

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8. Injected Currents Susceptibility Test

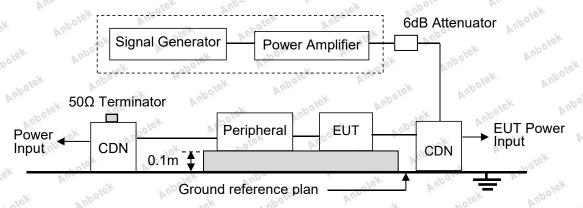
8.1. Test Specification

Test Standard:	EN 50121-3-2
Basic standard:	IEC 61000-4-6: 2013
Performance criteria:	A Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Frequency range:	0.15MHz to 80MHz
Test level:	10V Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Modulation:	AM 80%, 1kHz sine-wave
Frequency Step:	1% of fundamental

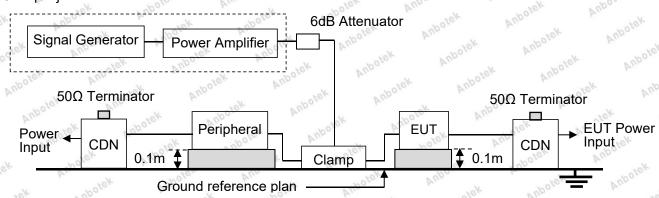
Report No.: 1819C40062512601-M1

8.2. Test Setup

CDN injection:



Clamp injection:



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Report No.: 1819C40062512601-M1 Page 32 of 42

8.3. Test Procedure

- a. The EUT and peripheral are placed on an insulating support of 0.1 m height above a ground reference plan. The distance between EUT and CDN is 0.1 m to 0.3 m. All cables exiting the EUT are supported at a height of at least 30 mm above the ground reference plan.
- b. The frequency range is swept from 150 kHz to 80MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. The frequency range is swept incrementally. The step size was 1% of fundamental from 0.15MHz to 80MHz.
- c. The dwell time at each frequency isn't less than the time necessary for the EUT to be able to respond.

8.4. Test Results

PASS

Please refer to the following page.

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Injected Currents Susceptibility Test Results

Report No.: 1819C40062512601-M1

487		· · · · · · · · · · · · · · · · · · ·	VI.
Test Result:	⊠ Pass □ Fail	Temperature:	24.4℃
Power Supply:	AC 230V, 50Hz	Humidity:	54%
ok abotek A	"upo, y work	Aupore, Yun	anbotek Anbo
Frequency Range (MHz)	Injected Position	Strength (Un-modulated)	Result
0.15 ~ 80	⊠ AC Mains	10V	⊠A □B □C
0.15 ~ 80	☐ DC Line	10V notek	□А □В □С
0.15 ~ 80	☐ Signal Line	Anbotek 10V Anbotek	□А □В □С
Note: N/A	Anbotek Anbotek	Aupotek Aupot	rek Anborek An



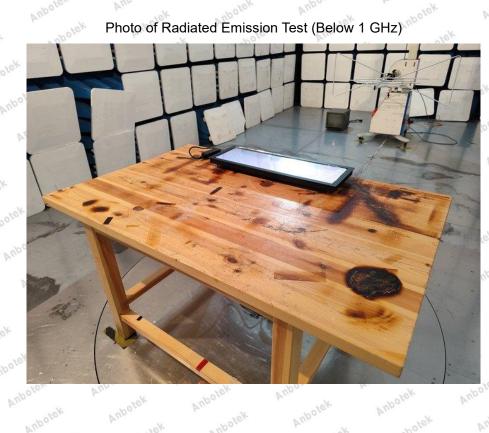
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APPENDIX I -- TEST SETUP PHOTOGRAPH

Report No.: 1819C40062512601-M1





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Report No.: 1819C40062512601-M1

Photo of Electrostatic Discharge Immunity Test

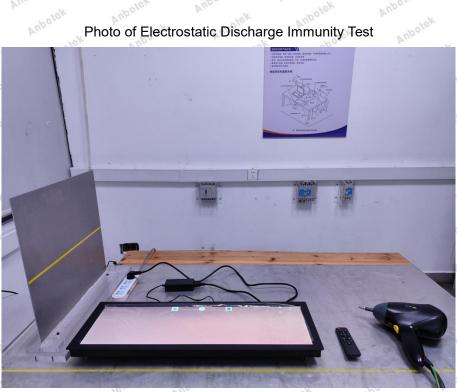


Photo of RF Field Strength Immunity Test



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Photo of Electrical Fast Transient/Burst Immunity Test

Report No.: 1819C40062512601-M1

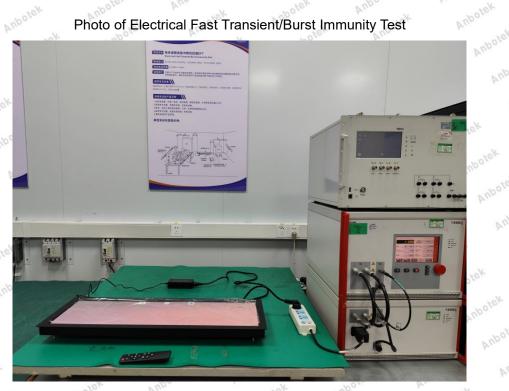
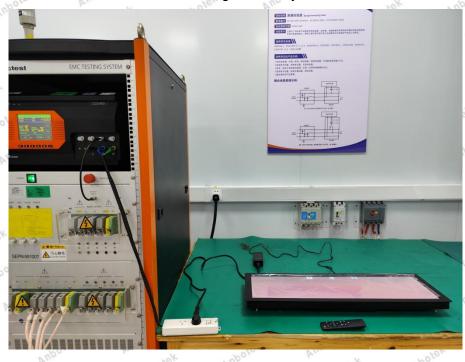


Photo of Surge Immunity Test



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Report No.: 1819C40062512601-M1

Photo of Injected Currents Susceptibility Test



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APPENDIX II -- Photo documentation

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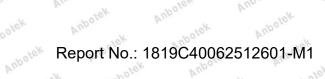
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Anbotek Anbotek Page 39 of 42

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Report No.: 1819C40062512601-M1

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Anbotek Page 41 of 42

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CE Label

Report No.: 1819C40062512601-M1

- The CE conformity marking must consist of the initials 'CE' taking the following form:
 If the CE marking is reduced or enlarged, the proportions given in the above graduated drawing must be respected.
- 2. The CE marking must have a height of at least 5 mm except where this is not possible on account of the nature of the apparatus.
- The CE marking must be affixed to the product or to its data plate. Additionally it must be affixed to the packaging, if any, and to the accompanying documents.
- 4. The CE marking must be affixed visibly, legibly and indelibly.

 It must have the same height as the initials 'CE'.

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